

# **Notice of References Cited**

Application/Control No. <b>09/867,286</b>		Applicant(s)/Patent Under Reexam <b>Ried et al.</b>	
Examiner <b>H. Kwok</b>		Art Unit <b>2856</b>	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,652,384	7/1997	Henrion et al.	73	514.24
B	US 2002/0178817	12/2002	Selvakumar et al.	73	514.32
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## **FOREIGN PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
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## **NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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